

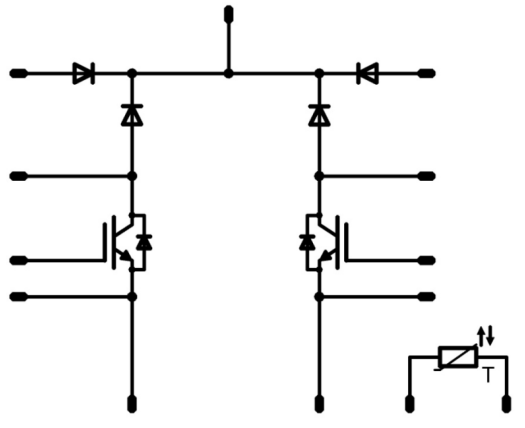




<i>flow</i> BOOST 0	1200 V / 40 A
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Features</div> <ul style="list-style-type: none"> Ultra fast switching frequency Low Inductance Layout 1200V IGBT and 1200V SiC diode Antiparallel IGBT protection diode with high current Improved thermal Rth (AlN) 	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">flow 0 17mm housing</div> <div style="display: flex; justify-content: space-around;">   </div> <div style="display: flex; justify-content: space-around; font-size: small;"> Solder Pin Press-fit </div>
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Target applications</div> <ul style="list-style-type: none"> Solar inverter 	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Schematic</div> 
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Types</div> <ul style="list-style-type: none"> V23990-P629-L94-PM V23990-P629-L94Y-PM 	

Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Boost Switch				
Collector-emitter voltage	V_{CES}		1200	V
Collector current	I_C	$T_j = T_{jmax}$ $T_S = 80^{\circ}\text{C}$	55	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	160	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_S = 80^{\circ}\text{C}$	200	W
Gate-emitter voltage	V_{GES}		± 25	V
Short circuit ratings	t_{SC}	$T_j \leq 125^{\circ}\text{C}$	10	μs
	V_{CC}	$V_{GE} = 15\text{V}$	600	V
Maximum Junction Temperature	T_{jmax}		150	$^{\circ}\text{C}$



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Parameter	Symbol	Conditions	Value	Unit
Boost Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$	53	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$	161	W
Maximum Junction Temperature	T_{jmax}		175	$^\circ\text{C}$

Parameter	Symbol	Conditions	Value	Unit
Boost Inverse Diode\Bypass Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		1600	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$	43	A
Surge (non-repetitive) forward current	I_{FSM}	50 Hz Single Half Sine Wave $T_j = 150^\circ\text{C}$	200	A
Surge current capability	I^2t	$t_p = 10\text{ ms}$ 50 Hz sine	200	A^2s
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$	63	W
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$

Parameter	Symbol	Conditions	Value	Unit
Module Properties				
Thermal Properties				
Storage temperature	T_{stg}		-40...+125	$^\circ\text{C}$
Operation Junction Temperature	T_{jop}		-40...+($T_{jmax} - 25$)	$^\circ\text{C}$

Isolation Properties					
Isolation voltage	V_{isol}	DC voltage	$t_p=2\text{s}$	4000	V
Creepage distance				min 12,7	mm
Clearance				min 12,7	mm
Comparative Tracking Index	CTI			>200	



Characteristic Values

Boost Switch

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V]	V_{CE} [V]	I_C [A]	T_j [°C]	Min	Typ	Max		
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}$			0,00025	25 125	3,5	5,5	7,5	V
Collector-emitter saturation voltage	V_{CEsat}		15		40	25 125 150		2,74 3,01 -	3,2	V
Collector-emitter cut-off current	I_{CES}		0	1200		25 125			1000	μA
Gate-emitter leakage current	I_{GES}		25	0		25 125			300	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f=1 MHz	0	30		25		3200		pF
Output capacitance	C_{oes}							370		
Reverse transfer capacitance	C_{res}							125		
Gate charge	Q_g		15	600	40	25		220	330	nC

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness=76μm Kunze foil KU-ALF5						0,35		K/W
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IGBT Switching

Turn-on delay time	$t_{d(on)}$	$R_{goff} = 4 \Omega$ $R_{gon} = 4 \Omega$	15/0	700	40	25		23		ns
Rise time	t_r					125		22		
Turn-off delay time	$t_{d(off)}$					25		165		
Fall time	t_f					125		197		
Turn-on energy (per pulse)	E_{on}	$Q_{fFWD} = 0,2 \mu C$ $Q_{rFWD} = 0,2 \mu C$				25		0,468		mWs
						125		0,570		
Turn-off energy (per pulse)	E_{off}					25		1,114		
						125		2,130		



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Boost Diode

Parameter	Symbol	Conditions					Value			Unit
		V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max			
Static										
Forward voltage	V_F		30	25 125 150			1,43 1,76 1,89	1,4		V
Reverse leakage current	I_r		1200	25 150				30 240		μA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness=76μm Kunze foil KU-ALF5					0,59			K/W

FWD Switching

Peak recovery current	I_{RRM}	$di/dt = 4133 A/\mu s$ $di/dt = 4920 A/\mu s$	15/0	700	40	25		31		A
Reverse recovery time	t_{rr}					125		27		ns
Recovered charge	Q_r					25		11		μC
Reverse recovered energy	E_{rec}					125		0,164 0,162		mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25		0,019 0,020		A/μs
		125		9136 6232						

Boost Inverse Diode\Bypass Diode

Parameter	Symbol	Conditions					Value			Unit
		V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max			
Static										
Forward voltage	V_F		25	25 125			1,22 1,21	1,9		V
Reverse leakage current	I_r		1600	25 150				50 1100		μA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal foil thickness=76μm Kunze foil KU-ALF5					1,11			K/W



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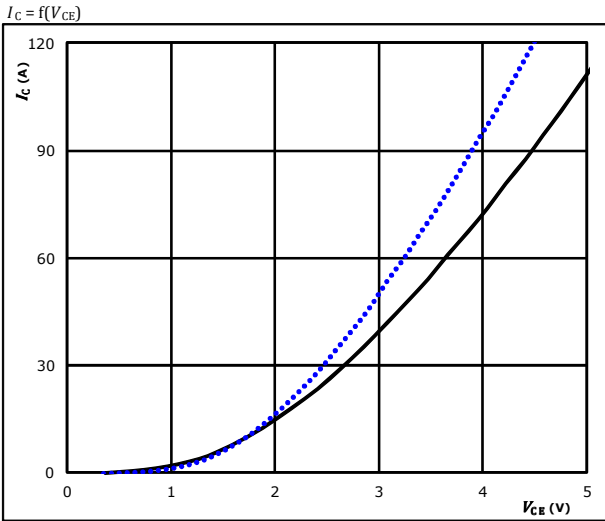
Thermistor

Parameter	Symbol	Conditions				Value			Unit
		V_{GE} [V]	V_{CE} [V]	I_C [A]	T_{j1} [°C]	Min	Typ	Max	
Rated resistance	R				25		21,5		kΩ
Deviation of R100	$\Delta_{R/R}$	R100=1486 Ω			100	-4,5		+4,5	%
Power dissipation	P				25		210		mW
Power dissipation constant					25		3,5		mW/K
B-value	$B_{(25/50)}$				25		3884		K
B-value	$B_{(25/100)}$				25		3964		K
Vincotech NTC Reference								F	



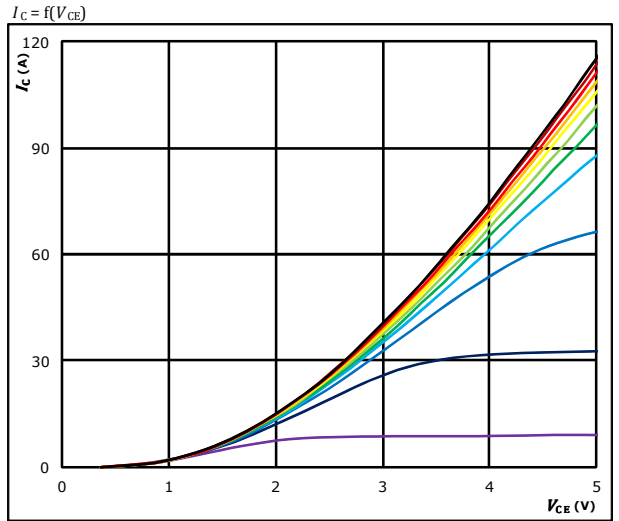
Boost Switch Characteristics

Typical output characteristics IGBT



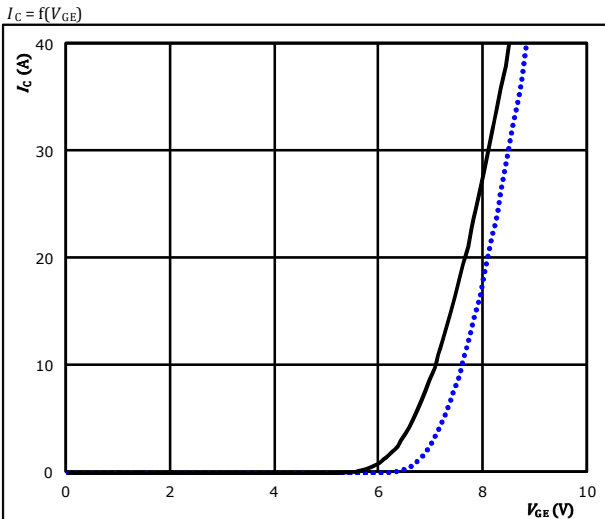
$t_p = 250 \mu s$
 $V_{GE} = 15 V$
25 °C (dotted blue)
125 °C (solid black)
150 °C (dashed red)

Typical output characteristics IGBT



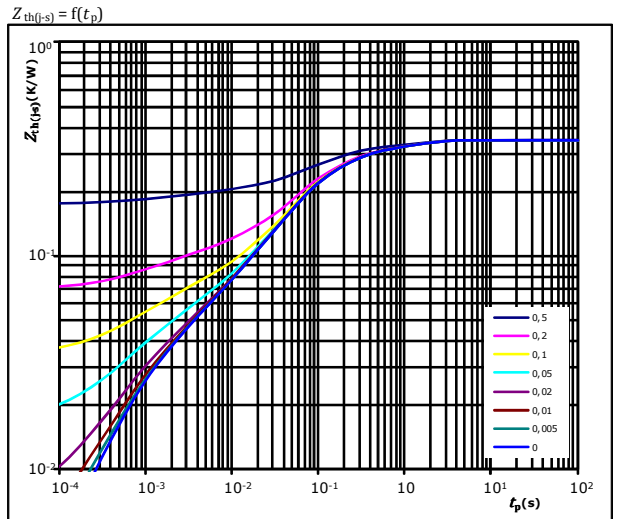
$t_p = 250 \mu s$
 $T_j = 125 \text{ °C}$
 V_{GE} from 7 V to 17 V in steps of 1 V

Typical transfer characteristics IGBT



$t_p = 100 \mu s$
 $V_{CE} = 10 V$
25 °C (dotted blue)
125 °C (solid black)
150 °C (dashed red)

Transient Thermal Impedance as function of Pulse duration IGBT



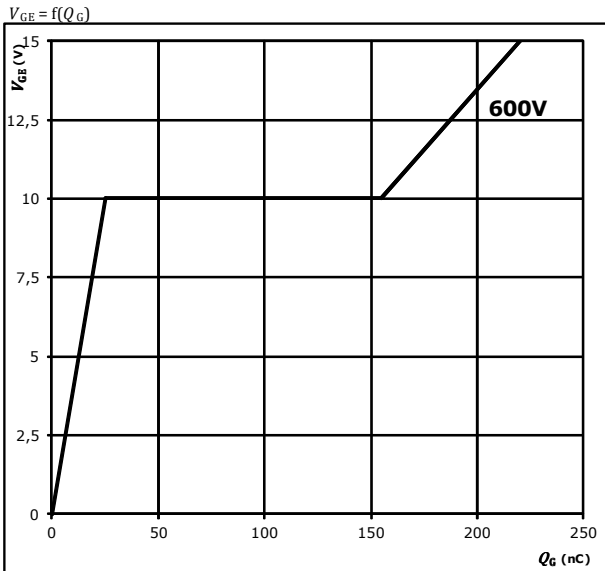
$D = t_p / T$
 $R_{th(j-s)} = 0,35 K/W$
IGBT thermal model values

$R_{th} (K/W)$	$\tau (s)$
7,21E-02	8,77E-01
1,40E-01	1,20E-01
1,02E-01	4,04E-02
2,88E-02	2,88E-03
1,74E-02	5,58E-04



Boost Switch Characteristics

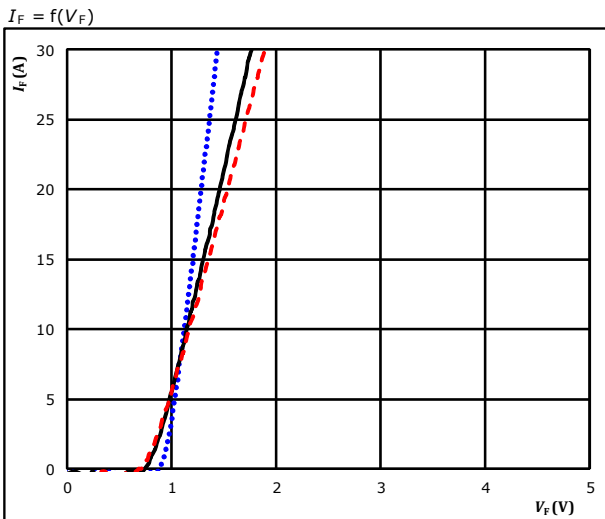
Gate voltage vs Gate charge IGBT



At
 $I_C = 40$ A

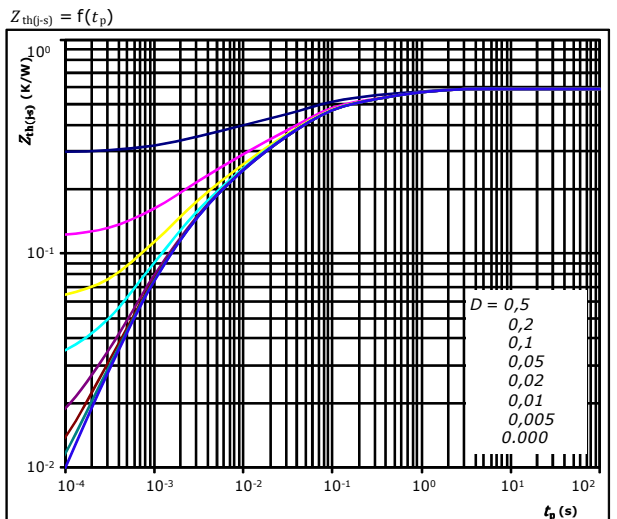
Boost Inverse Diode \ Bypass Diode Characteristics

Typical forward characteristics FWD



$t_p = 250$ μ s
 T_j : 25 °C
 125 °C ———
 150 °C - - - -

Transient thermal impedance as a function of pulse width FWD



$D = t_p / T$
 $R_{th(j-s)} = 0,59$ K/W

FWD thermal model values

R (K/W)	τ (s)
9,96E-02	6,21E-01
2,05E-01	5,72E-02
1,13E-01	1,89E-02
1,14E-01	3,85E-03
5,90E-02	9,59E-04

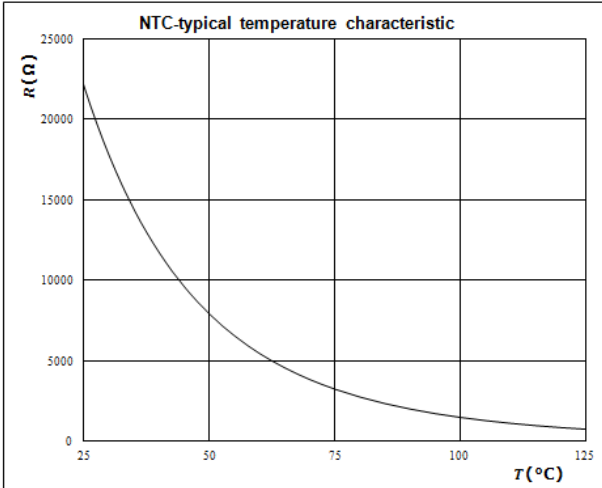


Thermistor Characteristics

Thermistor typical temperature characteristic

Typical NTC characteristic
as a function of temperature

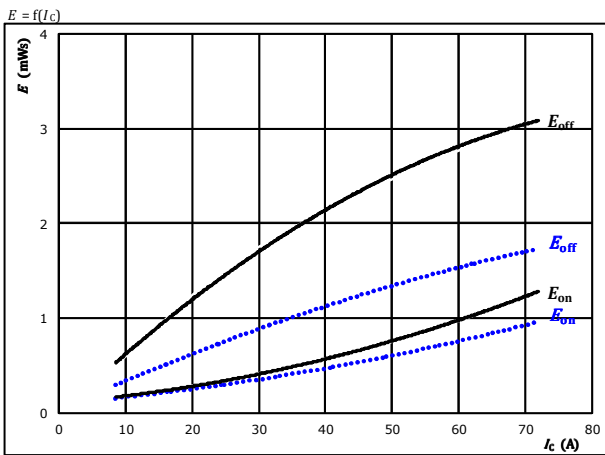
$$R_T = f(T)$$





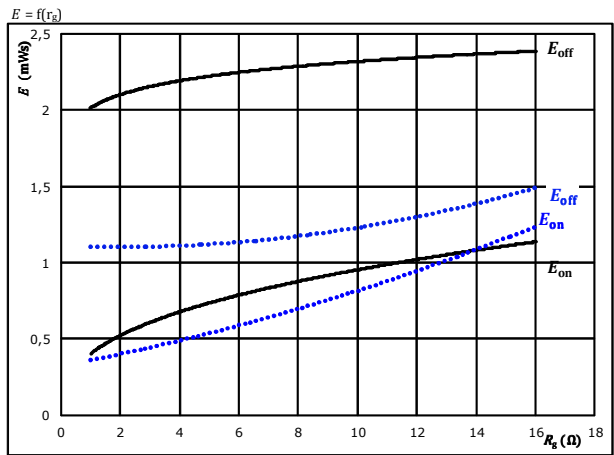
Boost Switching Characteristics

Figure 1. IGBT
Typical switching energy losses as a function of collector current



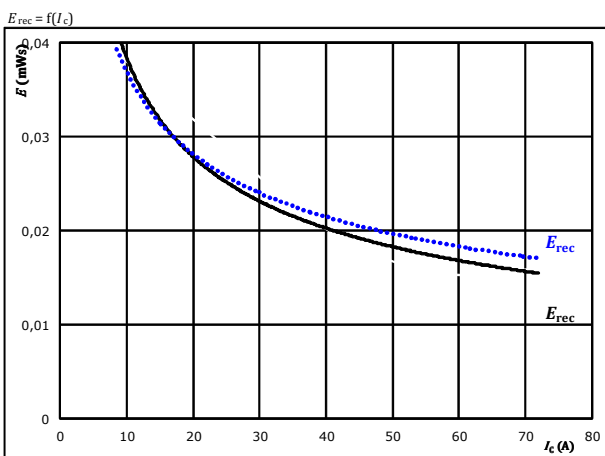
With an inductive load at
 $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $R_{gpn} = 4$ Ω
 $R_{goff} = 4$ Ω
 T_j : 25 °C (dotted blue), 125 °C (solid black), 150 °C (dashed red)

Figure 2. IGBT
Typical switching energy losses as a function of gate resistor



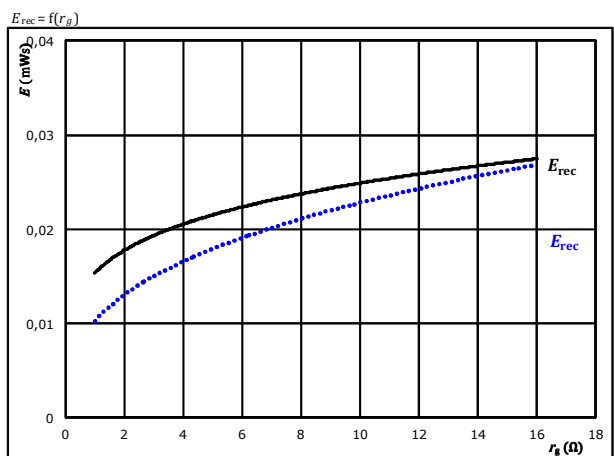
With an inductive load at
 $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $I_C = 40$ A
 T_j : 25 °C (dotted blue), 125 °C (solid black), 150 °C (dashed red)

Figure 3. FWD
Typical reverse recovered energy loss as a function of collector current



With an inductive load at
 $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $R_{gpn} = 4$ Ω
 T_j : 25 °C (dotted blue), 125 °C (solid black), 150 °C (dashed red)

Figure 4. FWD
Typical reverse recovered energy loss as a function of gate resistor



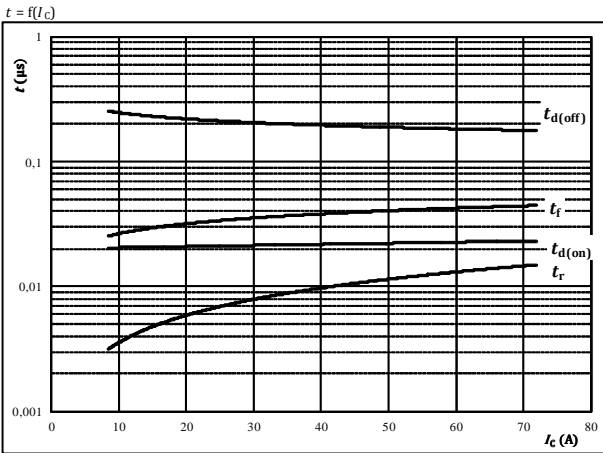
With an inductive load at
 $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $I_C = 40$ A
 T_j : 25 °C (dotted blue), 125 °C (solid black), 150 °C (dashed red)



Boost Switching Characteristics

Figure 5. IGBT

Typical switching times as a function of collector current

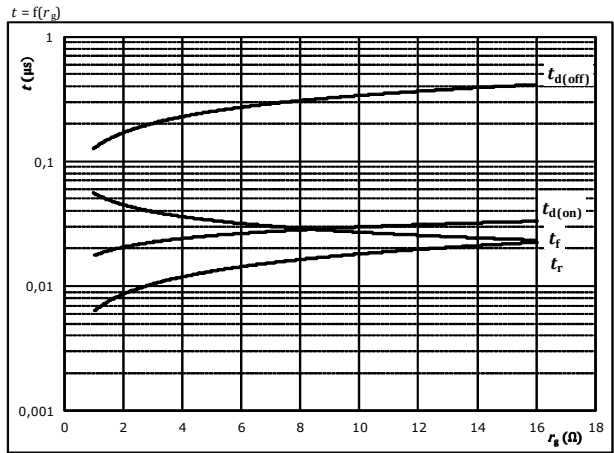


With an inductive load at

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15/0 \text{ V}$
 $R_{gdn} = 4 \text{ } \Omega$
 $R_{goff} = 4 \text{ } \Omega$

Figure 6. IGBT

Typical switching times as a function of gate resistor

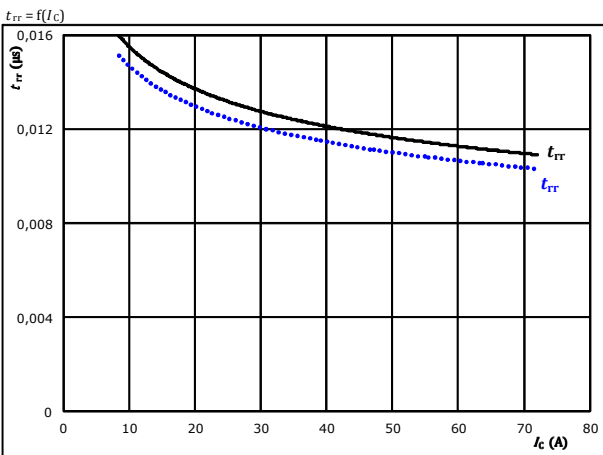


With an inductive load at

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15/0 \text{ V}$
 $I_C = 40 \text{ A}$

Figure 7. FWD

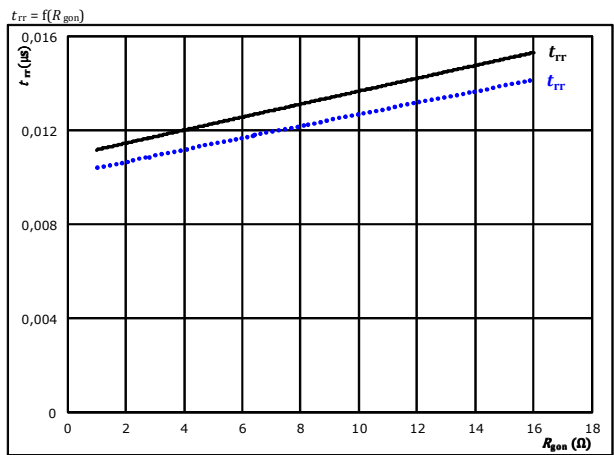
Typical reverse recovery time as a function of collector current



At $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15/0 \text{ V}$
 $R_{gdn} = 4 \text{ } \Omega$
 $T_j: 25 \text{ }^\circ\text{C}$ (dotted blue line)
 $125 \text{ }^\circ\text{C}$ (solid black line)
 $150 \text{ }^\circ\text{C}$ (dashed red line)

Figure 8. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

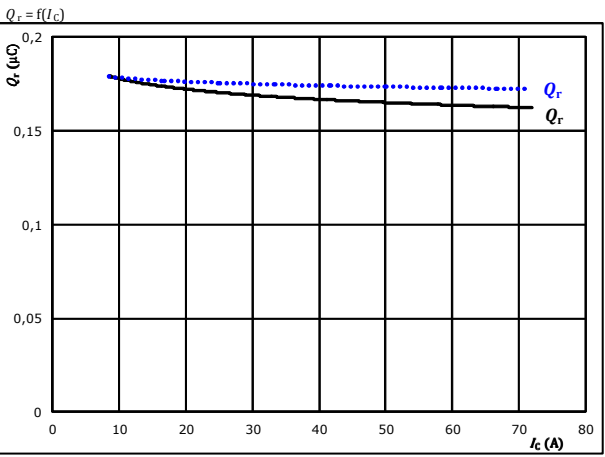


At $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15/0 \text{ V}$
 $I_C = 40 \text{ A}$
 $T_j: 25 \text{ }^\circ\text{C}$ (dotted blue line)
 $125 \text{ }^\circ\text{C}$ (solid black line)
 $150 \text{ }^\circ\text{C}$ (dashed red line)



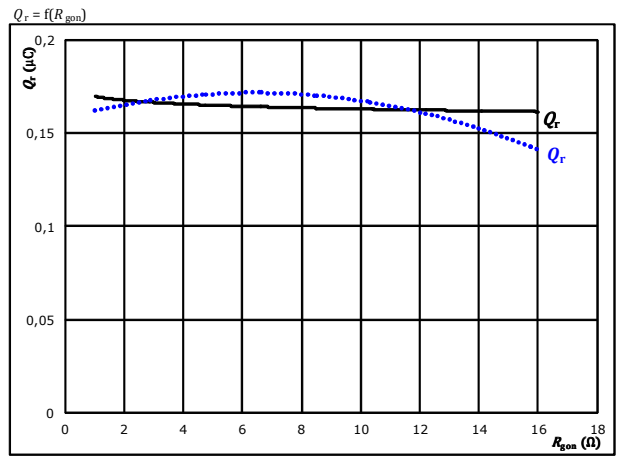
Boost Switching Characteristics

Figure 9. Typical recovered charge as a function of collector current FWD



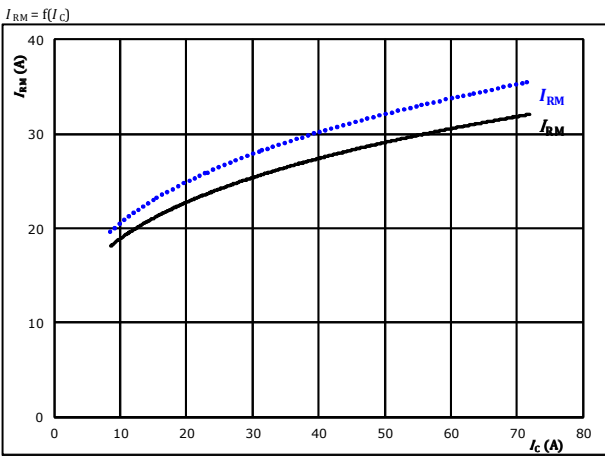
At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $R_{gpn} = 4$ Ω
 T_j : 25 °C (dotted blue line)
 125 °C (solid black line)
 150 °C (dashed red line)

Figure 10. Typical recovered charge as a function of IGBT turn on gate resistor FWD



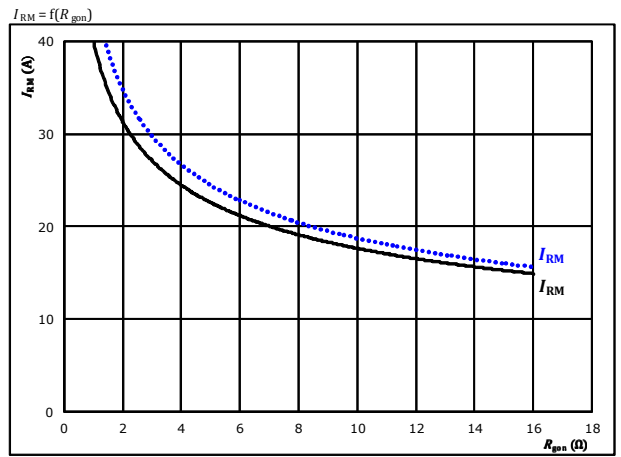
At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $I_c = 40$ A
 T_j : 25 °C (dotted blue line)
 125 °C (solid black line)
 150 °C (dashed red line)

Figure 11. Typical peak reverse recovery current as a function of collector current FWD



At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $R_{gpn} = 4$ Ω
 T_j : 25 °C (dotted blue line)
 125 °C (solid black line)
 150 °C (dashed red line)

Figure 12. Typical peak reverse recovery current as a function of IGBT turn on gate resistor FWD



At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $I_c = 40$ A
 T_j : 25 °C (dotted blue line)
 125 °C (solid black line)
 150 °C (dashed red line)

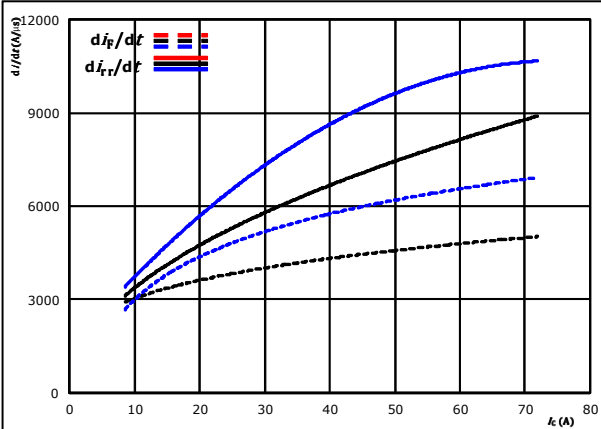


Boost Switching Characteristics

Figure 13. FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$di_F/dt, di_{rr}/dt = f(I_C)$$



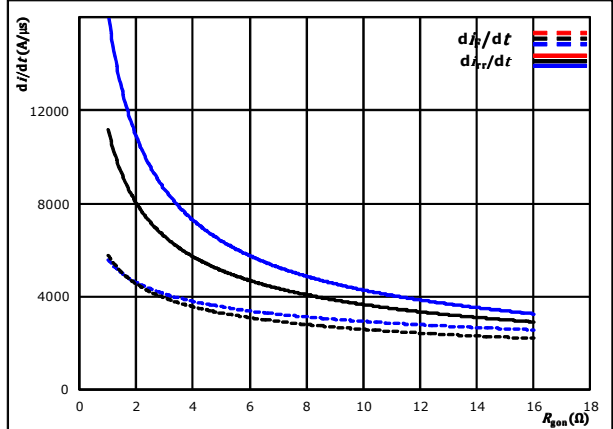
At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $R_{gon} = 4$ Ω

T_j : 25 °C (dotted blue)
125 °C (solid black)
150 °C (dashed red)

Figure 14. FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$di_F/dt, di_{rr}/dt = f(R_g)$$

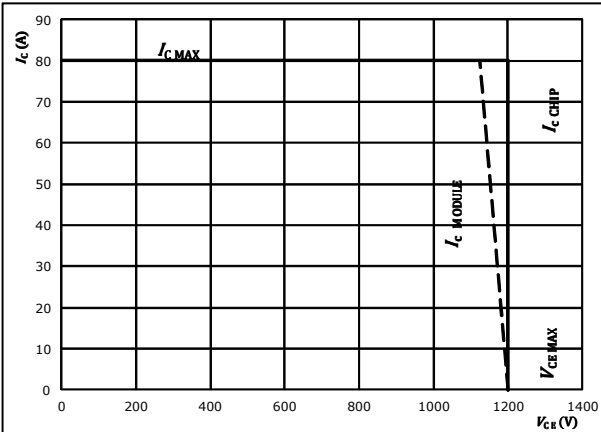


At $V_{CE} = 700$ V
 $V_{GE} = 15/0$ V
 $I_C = 40$ A

Figure 15. IGBT

Reverse bias safe operating area

$$I_C = f(V_{CE})$$



At $T_j = 175$ °C
 $R_{gon} = 4$ Ω
 $R_{goff} = 4$ Ω



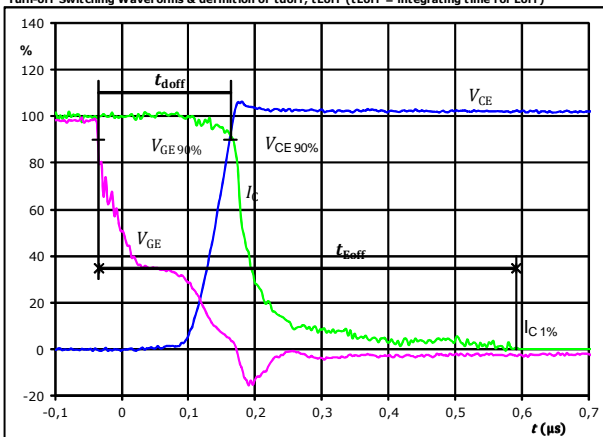
Boost Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

Figure 1. IGBT

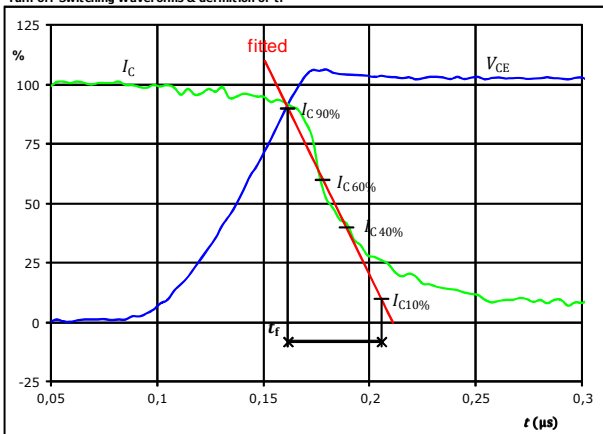
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%) =$	0	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_{doff} =$	0,197	μs
$t_{Eoff} =$	0,626	μs

Figure 3. IGBT

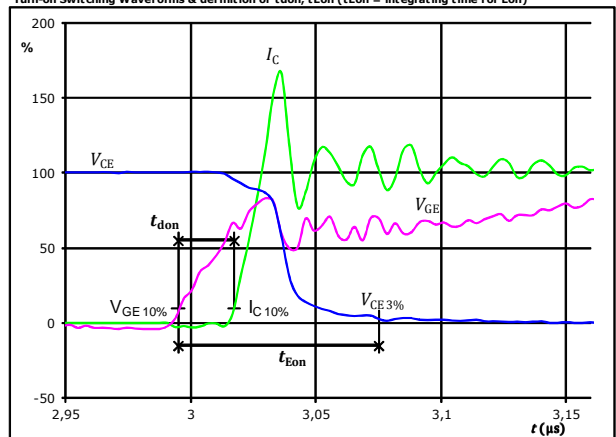
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_f =$	0,049	μs

Figure 2. IGBT

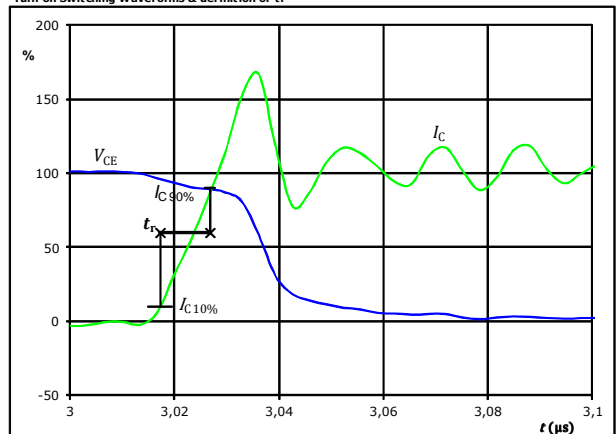
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%) =$	0	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_{don} =$	0,022	μs
$t_{Eon} =$	0,080	μs

Figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r



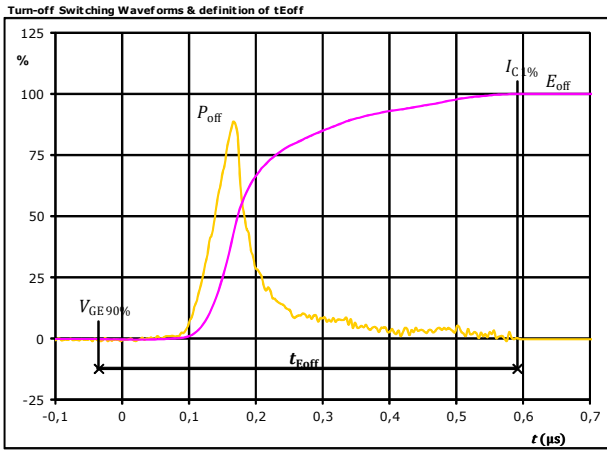
$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_r =$	0,010	μs



Vincotech

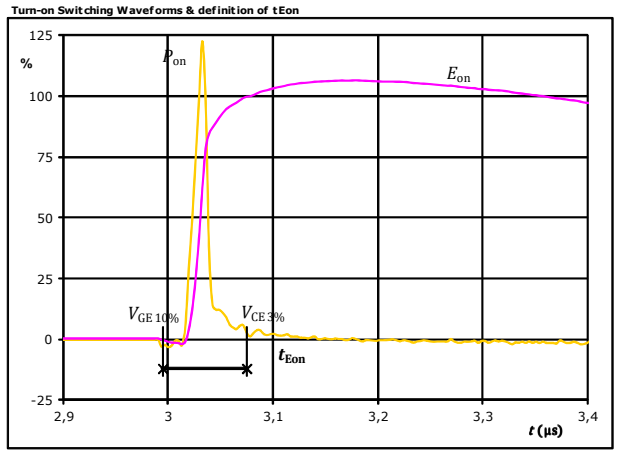
Boost Switching Definitions

Figure 5. IGBT



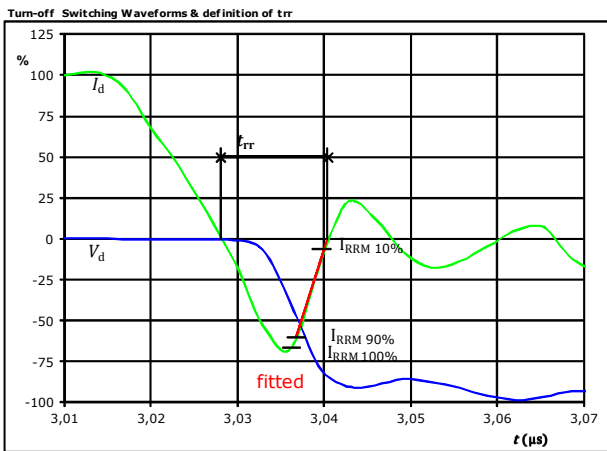
$P_{off}(100\%) =$	27,89	kW
$E_{off}(100\%) =$	2,13	mJ
$t_{Eoff} =$	0,63	μs

Figure 6. IGBT



$P_{on}(100\%) =$	27,89	kW
$E_{on}(100\%) =$	0,57	mJ
$t_{Eon} =$	0,08	μs

Figure 7. FWD

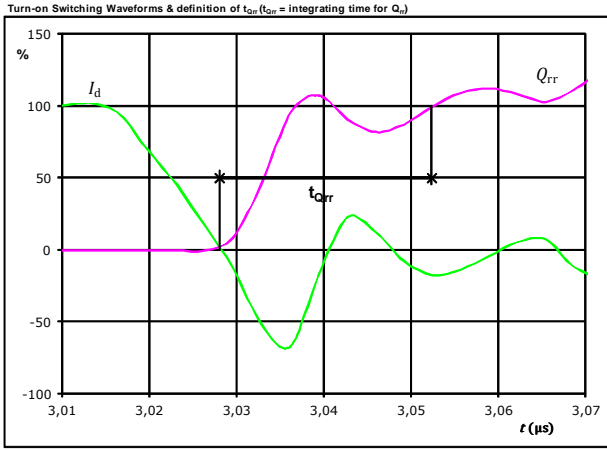


$V_d(100\%) =$	700	V
$I_d(100\%) =$	40	A
$I_{RRM}(100\%) =$	-27	A
$t_{rr} =$	0,012	μs



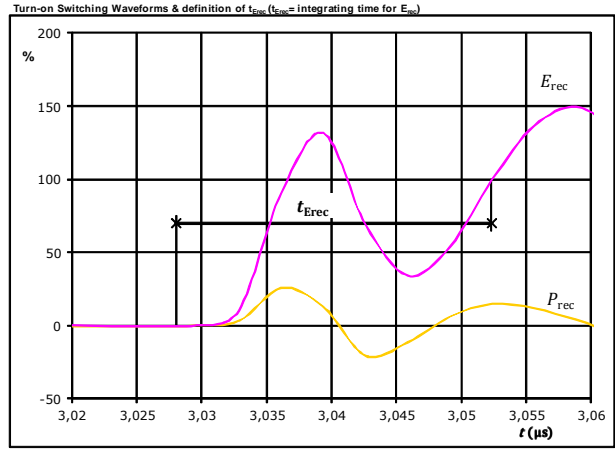
Boost Switching Definitions

Figure 8. FWD



$I_d(100\%) =$	40	A
$Q_{rr}(100\%) =$	0,16	μC
$t_{Qrr} =$	0,02	μs

Figure 9. FWD



$P_{rec}(100\%) =$	27,89	kW
$E_{rec}(100\%) =$	0,02	mJ
$t_{Erec} =$	0,02	μs



Ordering Code & Marking																				
Version				Ordering Code																
w/o thermal paste 17mm housing with solder pins				V23990-P629-L94-PM																
w/o thermal paste 17mm housing with Press-fit pins				V23990-P629-L94Y-PM																
<table border="1"> <thead> <tr> <th rowspan="2">Text</th> <th>Vinco</th> <th>Date code</th> <th>Name&Ver</th> <th>UL</th> <th>Lot</th> <th>Serial</th> </tr> </thead> <tbody> <tr> <td>Vinco</td> <td>WWYY</td> <td>NNNNNNVV</td> <td>UL</td> <td>LLLL</td> <td>SSSS</td> </tr> </tbody> </table>								Text	Vinco	Date code	Name&Ver	UL	Lot	Serial	Vinco	WWYY	NNNNNNVV	UL	LLLL	SSSS
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Pin table [mm]			
Pin	X	Y	Function
1	0	22,5	G1
2	2,9	22,5	S1
3	8,3	22,5	DC-Boost1
4	10,8	22,5	DC-Boost2
5	19,6	22,5	DC+Boost
6	22,1	22,5	DC+Boost
7	29,1	22,5	DC+In1
8	32	22,5	DC+In1
9	33,5	17,8	Boost1
10	33,5	15,3	Boost1
11	33,5	7,2	Boost2
12	33,5	4,7	Boost2
13	32	0	DC+In2
14	29,1	0	DC+In2
15	22,1	0	DC+Boost
16	19,6	0	DC+Boost
17	10,8	0	DC-Boost2
18	8,3	0	DC-Boost2
19	2,9	0	S2
20	0	0	G2
21	0	8	Therm1
22	0	14,5	Therm2

center of press-fit pinhead
for connection parameter see the handling instruction

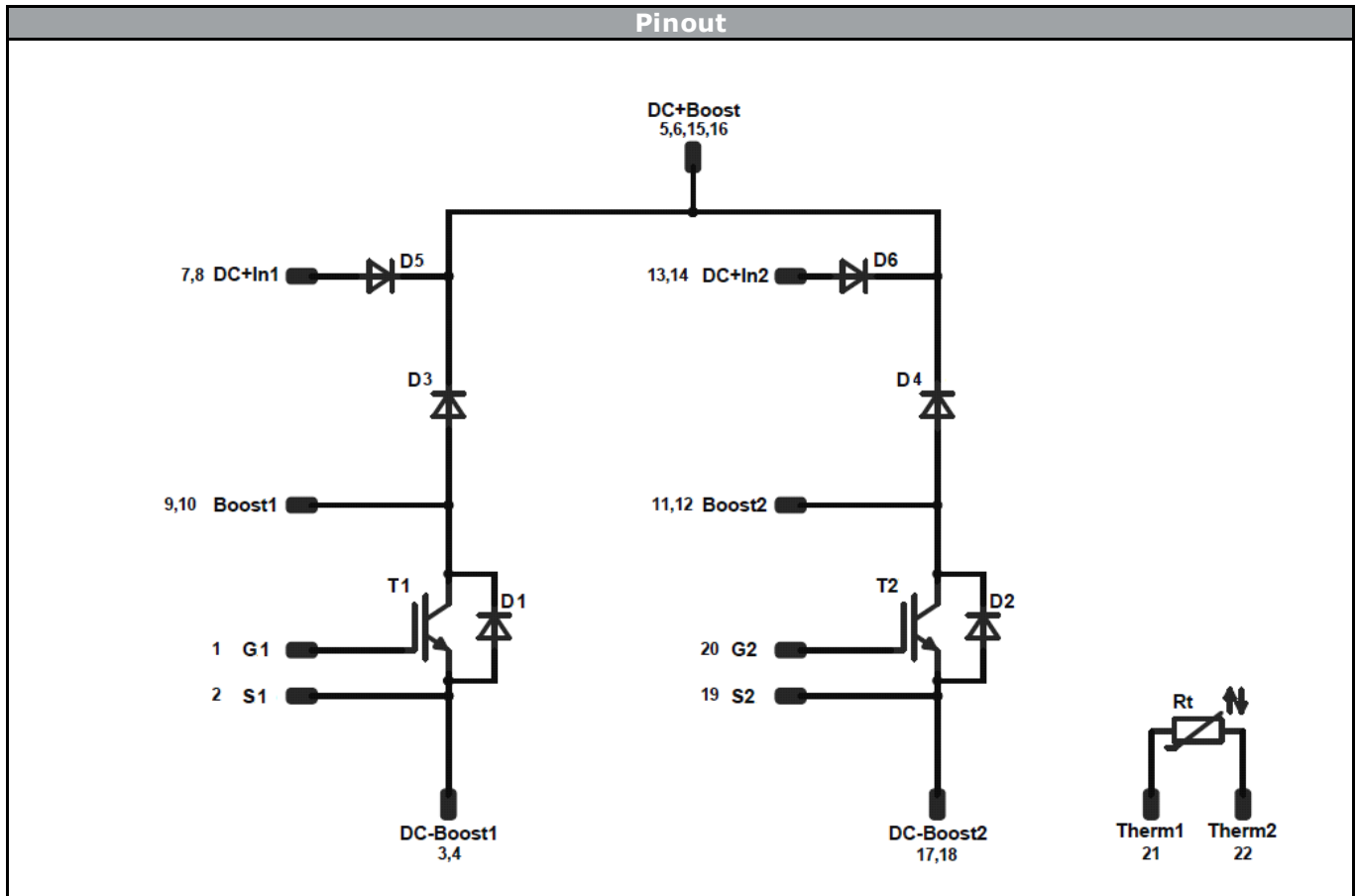
17,93 ±0,1
21,2 ±0,5

11,25
16,75

Tolerance of pinpositions: ±0,5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance



Vincotech



Identification					
ID	Component	Voltage	Current	Function	Comment
T1,T2	IGBT	1200V	40A	Boost Switch	FGL40N120ANDT
D3,D4	FWD	1200V	30A	Boost Diode	S6302TCS
D1,D2	Rectifier	1600V	25A	Boost Inverse Diode	SKR 3,5QU/16B
D5,D6	Rectifier	1600V	25A	Bypass Diode	SKR 3,5QU/16B
Rt	NTC	-	-	Thermistor	



Packaging instruction					
Standard packaging quantity (SPQ)	135	>SPQ	Standard	<SPQ	Sample

Handling instruction	
Handling instructions for <i>flow</i> 0 packages see vincotech.com website.	

Package data	
Package data for <i>flow</i> 0 packages see vincotech.com website.	

Document No.:	Date:	Modification:	Pages
V23990-P629-L94x-D2-14	4 Dec. 2015	Added Press-fit option	1, 16

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.